Search Notes			

Application/Control N .	Applicant(s)/Patent under Reexamination	
10/531,956	MAEDA ET AL.	
Examiner .	Art Unit	
TUYEN T. NGUYEN	2832	

SEARCHED			
Class	Subclass	Date	Examiner
336	65, 83, 200, 232	5/29/2006	TTN
updated		9/16/06	TIN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner ·
Same	ebre	9/18/06	TTN

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